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TEST REPORT

Application No.:	SZEM1806005390CR
Applicant:	HANK ELECTRONICS CO., LTD.
Address of Applicant:	Floor 2nd-7th, A8, Hongye Industry City Lezhujiao, Zhoushi Road, Baoan District, Shenzhen, China
Manufacturer:	HANK ELECTRONICS CO., LTD.
Address of Manufacturer:	Floor 2nd-7th, A8, Hongye Industry City Lezhujiao, Zhoushi Road, Baoan District, Shenzhen, China
Factory:	HANK ELECTRONICS CO., LTD.
Address of Factory:	Floor 2nd-7th, A8, Hongye Industry City Lezhujiao, Zhoushi Road, Baoan District, Shenzhen, China
Equipment Under Test (EUT):
EUT Name:	Wireless Charger Pad
Model No.:	HKWP1161-05, HKWP1161-10Q, STG-6426-KB, PCHQIT10 🌲
*	Please refer to section 2 of this report which indicates which model was actually tested and which were electrically identical.
FCC ID:	2AIOC-1161
Standard(s) :	47 CFR Part 18
Date of Receipt:	2018-06-21
Date of Test:	2018-06-23 to 2018-06-25
Date of Issue:	2018-06-28
Test Result:	Pass*

* In the configuration tested, the EUT complied with the standards specified above.



EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.



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	Revision Record						
Version	ersion Chapter Date Modifier Rema						
01		2018-06-28		Original			

Authorized for issue by:		
	Peter. Gong	
	Deter Oone (Decident Engineer	
	Peter Geng /Project Engineer	
	Evic Fu	
	Eric Fu /Reviewer	



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2 Test Summary

Radio Spectrum Matter Part							
Item	Standard	Method	Requirement	Result			
Conducted disturbance	47 CFR Part 18	FCC MP-5	Part 18.307	Pass			
Radiated emission	47 CFR Part 18	FCC MP-5	Part 18.305	Pass			

Remark:

Model No.: HKWP1161-05, HKWP1161-10Q, STG-6426-KB, PCHQIT10

Only the model HKWP1161-10Q was tested, since the electrical circuit design, layout, components used, internal wiring and functions were identical for the above models, with only difference on model number.



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	 4.2 DESCRIPTION OF SUPPORT UNITS



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4 General Information

4.1 Details of E.U.T.

Power supply:	input: DC 5V/2A, DC 9V/1.67A
	output: DC 5V/1A, DC 9V/1.1A
Cable:	USB line: 100cm, unshielded
Operation frequency:	113.2-162.1KHz
Modulation type:	Load modulation
Antenna type:	Inductive Loop Coil Antenna
Remark:	Tests were conducted in both load modes and the worst case(DC 5V/1A) is reported only.

4.2 Description of Support Units

Description	Manufacturer	Model No.	Serial No.
Adapter	Apple	A1357 W010A051	REF. No.SEA0500
E-loading	provided by client	N/A	DC 5V/1A
Mobile phone	Provided by SGS(SAMSUNG)	SM-G9500	R28J9140LPB

4.3 Measurement Uncertainty

No.	Item	Measurement Uncertainty
1	Radio Frequency	± 7.25 x 10 ⁻⁸
2	Duty cycle	± 0.37%
3	Occupied Bandwidth	± 3%
4	RF conducted power	± 0.75dB
5	RF power density	± 2.84dB
6	Conducted Spurious emissions	± 0.75dB
7	DE Dedicted newer	± 4.5dB (below 1GHz)
/	RF Radiated power	± 4.8dB (above 1GHz)
8	Dedicted Courieus emission test	± 4.5dB (Below 1GHz)
0	Radiated Spurious emission test	± 4.8dB (Above 1GHz)
9	Temperature test	± 1 ℃
10	Humidity test	± 3%
11	Supply voltages	± 1.5%
12	Time	± 3%



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4.4 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China. 518057.

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

4.5 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC

Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

• VCCI

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

• FCC – Designation Number: CN1178

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

4.6 Deviation from Standards

None

4.7 Abnormalities from Standard Conditions

None



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5 Equipment List

Conducted disturbance					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Shielding Room	ChangZhou ZhongYu	GB-88	SEM001-06	2017-05-10	2020-05-09
Measurement Software	AUDIX	e3 V5.4.1221d	N/A	N/A	N/A
Coaxial Cable	SGS	N/A	SEM024-01	2017-07-13	2018-07-12
LISN	Rohde & Schwarz	ENV216	SEM007-01	2017-09-27	2018-09-26
LISN	ETS-LINDGREN	3816/2	SEM007-02	2018-04-02	2019-04-01
EMI Test Receiver	Rohde & Schwarz	ESCI	SEM004-02	2018-04-02	2019-04-01

Radiated emission					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
10m Semi-Anechoic Chamber	SAEMC	FSAC1018	SEM001-03	2018-03-31	2021-03-30
Measurement Software	AUDIX	e3 V8.2014-6- 27	N/A	N/A	N/A
Coaxial Cable	SGS	N/A	SEM029-01	2017-07-13	2018-07-12
EMI Test Receiver (9kHz-3GHz)	Rohde & Schwarz	ESCI	SEM004-01	2018-04-02	2019-04-01
Trilog-Broadband Antenna (30MHz-1GHz)	Schwarzbeck	VULB9168	SEM003-18	2016-01-26	2019-01-25
Pre-amplifier	Sonoma Instrument Co	310N	SEM005-04	2018-04-13	2019-04-12
Active Loop Antenna	ETS-Lindgren	6502	SEM003-08	2017-08-22	2020-08-21

General used equipment					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	ZJ1-2B	SEM002-03	2017-09-29	2018-09-28
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	ZJ1-2B	SEM002-04	2017-09-29	2018-09-28
Humidity/ Temperature Indicator	Mingle	N/A	SEM002-08	2017-09-29	2018-09-28
Barometer	Changchun Meteorological Industry Factory	DYM3	SEM002-01	2018-04-08	2019-04-07



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6 Radio Spectrum Matter Test Results

6.1 Conducted disturbance

Test Requirement	Part 18.307
Test Method:	FCC MP-5
Limit:	

	Conducted limit (dBµV)		
Frequency of emission (MHz)	Quasi-peak	Average	
0.15-0.5	66 to 56*	56 to 46*	
0.5-5	56	46	
5-30	60	50	

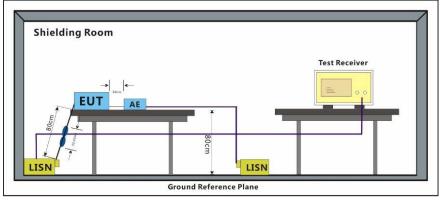
*Decreases with the logarithm of the frequency.

6.1.1 E.U.T. Operation

Operating Environment:

Temperature:25.8 °CHumidity:51.5 % RHAtmospheric Pressure:1010mbarTest modea:Charge mode_Keep the EUT charging

6.1.2 Test Setup Diagram

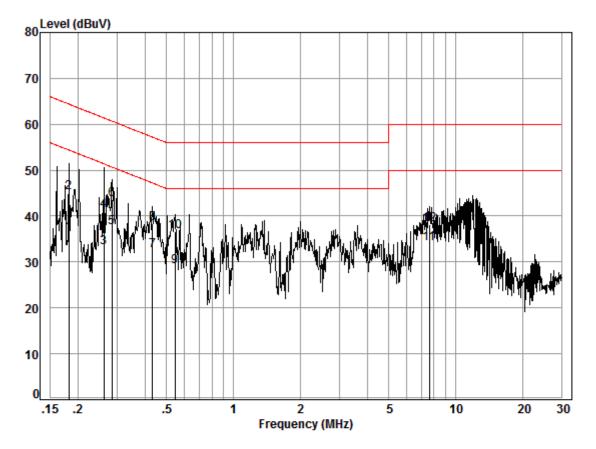


6.1.3 Measurement Procedure and Data



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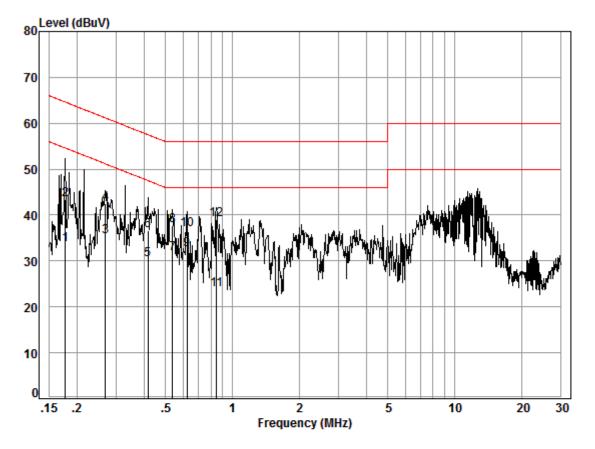
Site : Shielding Room Condition: Line Job No. : 05390CR Test mode: a

	Freq	Cable Loss	LISN Factor	Read Level	Level	Limit Line	Over Limit	Remark
	MHz	dB	dB	dBuV	dBuV	dBuV	dB	
1	0.18	0.03	9.51	26.59	36.13	54.42	-18.29	Average
2	0.18	0.03	9.51	35.62	45.16	64.42	-19.26	QP
3	0.26	0.03	9.51	23.67	33.21	51.38	-18.17	Average
4	0.26	0.03	9.51	31.68	41.22	61.38	-20.16	QP
5	0.28	0.03	9.51	27.88	37.42	50.68	-13.26	Average
6	0.28	0.03	9.51	34.07	43.61	60.68	-17.07	QP
7	0.43	0.04	9.49	22.85	32.38	47.20	-14.82	Average
8	0.43	0.04	9.49	28.92	38.45	57.20	-18.75	QP
9	0.55	0.05	9.51	19.47	29.03	46.00	-16.97	Average
10	0.55	0.05	9.51	26.96	36.52	56.00	-19.48	QP
11	7.61	0.18	9.60	24.13	33.91	50.00	-16.09	Average
12	7.61	0.18	9.60	28.34	38.12	60.00	-21.88	QP



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Mode:a; Line:Neutral Line



Site : Shielding Room Condition: Neutral Job No. : 05390CR Test mode: a

	Freq	Cable Loss	LISN Factor	Read Level	Level	Limit Line	Over Limit	Remark
	MHz	dB	dB	dBuV	dBuV	dBuV	dB	
1 2	0.18 0.18	0.03 0.03	9.59 9.59	23.98 33.87	33.60 43.49		-21.04 -21.15	Average
3	0.27	0.03	9.58	25.67	35.28	51.16	-15.88	Average
4 5	0.27 0.42	0.03 0.04	9.58 9.59	32.94 20.73	42.55 30.36		-18.61 -17.15	QP Average
6 7	0.42 0.54	0.04 0.05	9.59 9.61	26.96 21.94	36.59 31.60		-20.92	QP Average
8 9	0.54 0.62	0.05 0.06	9.61 9.62	28.09	37.75	56.00	-18.25	-
10	0.62	0.06	9.62	27.25	36.93	56.00	-19.07	QP
11 12	0.85 0.85	0.08 0.08	9.61 9.61	13.98 29.41	23.67 39.10		-22.33 -16.90	Average QP



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6.2 Radiated emission

Test RequirementPart 18.305Test Method:FCC MP-5Measurement Distance:10mLimit:

(b) The field strength levels of emissions which lie outside the bands specified in §18.301, unless otherwise indicated, shall not exceed the following:

Equipment	Operating frequency	RF Power generated by equipment (watts)	Field strength limit (uV/m)	Distance (meters)
Any type unless otherwise specified (miscellaneous)	Any ISM frequency	Below 500 500 or more	25 25 × SQRT(power/500)	300 ¹ 300
	Any non-ISM frequency	Below 500 500 or more	15 15 × SQRT(power/500)	300 ¹ 300
Industrial heaters and RF stabilized arc welders	On or below 5,725 MHz Above 5,725 MHz	Any Any	10 (²)	1,600 (²)
Medical diathermy	Any ISM frequency Any non-ISM frequency	Any Any	25 15	300 300
Ultrasonic	Below 490 kHz	Below 500 500 or more	2,400/F(kHz) 2,400/F(kHz) × SQRT (power/500)	300 ³ 300
	490 to 1,600 kHz Above 1,600 kHz	-	24,000/F(kHz) 15	30 30
Induction cooking ranges	Below 90 kHz On or above 90 kHz	Any Any	1,500 300	⁴ 30 ⁴ 30

¹Field strength may not exceed 10 μ V/m at 1600 meters. Consumer equipment operating below 1000 MHz is not permitted the increase in field strength otherwise permitted here for power over 500 watts.

²Reduced to the greatest extent possible.

 3 Field strength may not exceed 10 $\mu V/m$ at 1600 meters. Consumer equipment is not permitted the increase in field strength otherwise permitted here for over 500 watts.

⁴Induction cooking ranges manufactured prior to February 1, 1980, shall be subject to the field strength limits for miscellaneous ISM equipment.



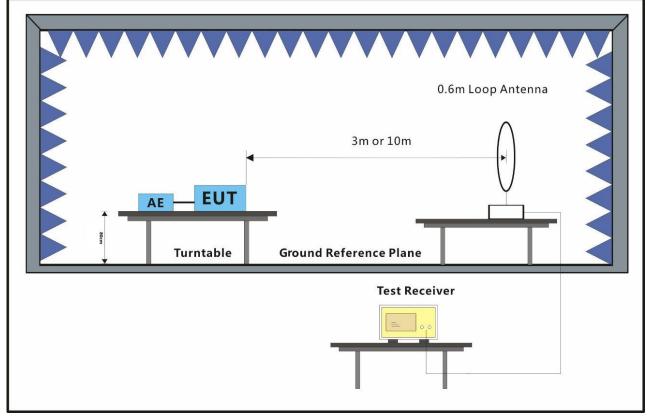
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6.2.1 E.U.T. Operation

Operating Environment:

Temperature:25 °CHumidity:51 % RHAtmospheric Pressure:1010 mbarTest modea:Charge mode_Keep the EUT charging

6.2.2 Test Setup Diagram

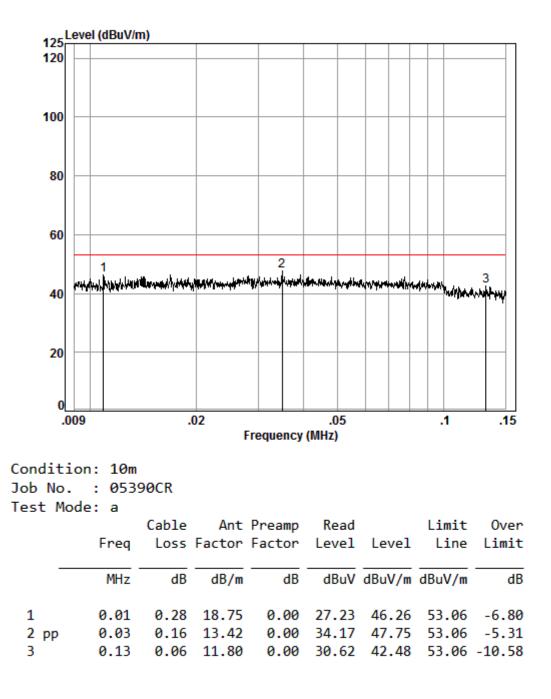


6.2.3 Measurement Procedure and Data



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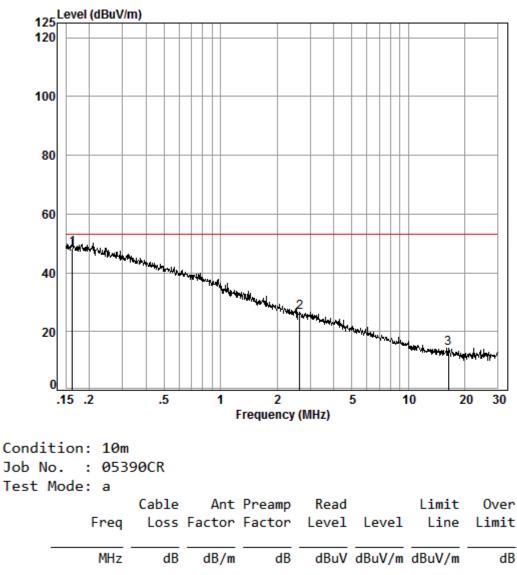
Mode a: 9KHz-150kHz





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Mode a: 150kHz-30MHz



1 pp	0.16	0.07	11.75	0.00	36.56	48.38	53.06	-4.68
2	2.64	0.37	12.17	0.00	14.12	26.66	53.06	-26.40
3	16.31	0.62	10.14	0.00	3.66	14.42	53.06	-38.64



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The test was performed at a 10m test site. According to below formulate and the test data at 10m test distance,

 $L_{300} / L_{10} = D_{10} / D_{300}$

Note:

L₃₀₀: Level @ 300m distance. Unit: uV/m;

L10: Level @ 10m distance. Unit: uV/m;

D₃₀₀: 300m distance. Unit: m

D₁₀: 10m distance. Unit: m

The level at 300m test distance is below:

Frequency (MHz)	Level @ 10m (dBuV/m)	Level @ 10m (uV/m)	Level @ 300m (uV/m)	Level @ 300m (dBuV/m)	Limit @ 300m (dBuV/m)	Margin (dB)
0.01	46.26	205.59	6.85	16.72	23.52	-6.80
0.03	47.75	244.06	8.14	18.21	23.52	-5.31
0.13	42.48	133.05	4.43	12.94	23.52	-10.58
0.16	48.38	262.42	8.75	18.84	23.52	-4.68
2.64	26.66	21.53	0.72	-2.88	23.52	-26.40
16.31	14.42	5.26	0.18	-15.12	23.52	-38.64

Remark:

1 This product belong to any non-ISM frequency equipment, the field strength limit is 15uV/m at 300 meter

2 Limit: 20log(15uV/m)=23.52dBuV/m



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7 Photographs

7.1 Conducted disturbance Test Setup



7.2 Radiated emission Test Setup





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7.3 EUT Constructional Details (EUT Photos)

Please refer to external and internal photos for details.

- End of the Report -